Enhanced Thermal Stability in Perovskite Solar Cells by Assembling 2D/3D Stacking Structures

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Supporting Information

ABSTRACT: Two-dimensional (2D) perovskites have been shown to be more stable than their three-dimensional (3D) counterparts due to the protection of the organic ligands. Herein a method is introduced to form 2D/3D stacking structures by the reaction of 3D perovskite with n-butylamine (BA). Different from regular treatment with n-butylammonium iodide (BAI) where 2D perovskite with various layers form, the reaction of BA with MAPbI3 only produce (BA)2PbI4, which has better protection due to more organic ligands in (BA)2PbI4 than the mixture of 2D perovskites. Compared to BAI treatment, BA treatment results in smoother 2D perovskite layer on 3D perovskites with a better coverage. The photovoltaic devices with 2D/3D stacking structures show much improved stability in comparison to their 3D counterparts when subjected to heat stress tests. Moreover, the conversion of defective surface into 2D layers also induces passivation of the 3D perovskites resulting in an enhanced efficiency.

Organic-inorganic halide perovskites have become a class of promising materials in the optoelectronic fields of solar cells,1 light emitting diodes,2 photodetectors,3 and radiation detectors4 owing to their outstanding optoelectronic properties.5–7 Three-dimensional perovskite polycrystalline thin films inevitably contain defects on surfaces and at grain boundaries,8,9 which can incur nonradiative charge recombination to reduce device efficiency and initiate the degradation of perovskites.10–12 Therefore, passivation of defects is necessary, and a lot of related research has been done to continuously improve the photovoltaic performance and stability.10–20 The record power efficiency of perovskite solar cells has reached over 22.1%.21 Compared to 3D perovskites, enhanced moisture stability has been observed in 2D perovskite materials.22–26 2D perovskites (PEA)2(MA)2PbI4 (PEA = C6H5(CH2)2NH3+, MA = CH3NH3+, PbI4−) are used as absorbers in solar cells; the powder X-ray diffraction of (PEA)2(MA)2PbI4 did not show obvious changes after exposure to 52% relative humidity for 46 days, while MAPbI3 completely converted to PbI2.22 A similar result that a film of (BA)2(MA)2PbI4 showed extremely high moisture stability was also reported.23 Despite high moisture stability, the efficiency of 2D perovskite solar cells is still quite low. The record power conversion efficiency (PCE) of 2D perovskite solar cells reported in the literature is 13.7%.27 In this sense, construction of 2D/3D stacking structures can combine the advantages of enhanced stability in 2D perovskites as well as the strong light absorption and good charge carrier transport properties in 3D perovskite materials. On the basis of our previous work, degradation of perovskite films was initialized from the defects sites on surfaces and at grain boundaries.28 Therefore, introducing a thin 2D perovskite layer to wrap the surface and grain boundary of 3D perovskites is promising to enhance the device stability while maintaining its high efficiency.

In this work, we report the construction of 2D/3D stacking structures by the reaction of n-butylamine (BA) with the surface of 3D perovskites. We found that the resulting 2D perovskite layers by two methods, i.e., BA and n-butylammonium iodide (BAI) treatments, had different compositions; therefore, the possible chemical reaction mechanisms are proposed. As a result, the introduction of a thin 2D perovskite layer on the surface and/or at the grain boundaries of 3D perovskites enhances the thermal stability of the finished photovoltaic devices. In addition, the thin 2D layers also have defect passivation and defect healing effects, which reduce the trap density, prolong the carrier lifetime, and increase the PCE to 19.56%.

The schematic illustration of the 2D/3D stacking structure is shown in Figure 1a. The one-step spin-coating method was employed to form polycrystalline MAPbI3 thin films. Then, in the following post-treatments, two kinds of solutions (BA dissolved in chlorobenzene (CB) and BAI dissolved in isopropanol alcohol (IPA)) were spun-coated on top of 3D perovskite layers. We expected that the BA or BAI molecules would gradually diffuse into the crystalline structure through surface and grain boundaries, reacting with MAPbI3 according to eqs 1 and 2.

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2BA + MAI + MAPbI₃ → (BA)₂PbI₄ + 2MA↑ (1)

2BAI + nMAPbI₃ ↔ (BA)₂(MA)ₙ₋₁PbI₃₊₁ + MAI (2)

As a result, thin layers of two-dimensional perovskites were generated on top of 3D perovskite polycrystalline films, forming the 2D/3D stacking structures. The molecular structures of the formed 2D layers are different, as illustrated in Figure 1bc.

Surface morphology changes of MAPbI₃ films treated by BA and BAI with optimized solution concentrations (see below) were observed by scanning electron microscopy (SEM). The morphology of pristine MAPbI₃ thin films in Figure 1d resembles that of typical perovskite films made by the one-step spin-coating method. After BA treatment, the surface became smoother (Figure 1e), which resembles the effect of amine gas treatment where the surfaces of perovskite films were dissolved by amine and re-formed after the amine evaporated. This smoother surface morphology indicates that the newly formed 2D perovskite layer can uniformly cover the 3D perovskites underneath. For BAI treatment, a clear surface morphology change was also observed (Figure 1f) where the surface was relatively rougher. This morphology change may be due to 3D to 2D phase transition. The RMS (root mean square) surface roughness values extracted from atomic force microscopy measurements (see Figure S1) reduce from 32.51 nm for pristine MAPbI₃ films to 16.87 and 18.95 nm after BA and BAI treatments, respectively.

XRD and UV–vis absorption measurements were conducted to verify the formation of 2D/3D stacking structure. The formed 2D perovskite layers are too thin to be detected in regular XRD and absorption measurements for the real post-treatment conditions used in the device fabrication; therefore, the post-treatment time for samples used here was intentionally prolonged. Figure 2a shows the XRD patterns of MAPbI₃ polycrystalline thin films before and after BA or BAI treatment for 3 min. The XRD pattern of pure 2D perovskite films with different n values (n represents the number of Pb–I sheets in each inorganic layer) can be found in a previous report. After BA treatment, some additional diffraction peaks showed up, which were indexed to be (002), (004), (006), and (008) planes of 2D perovskite (BA)₂PbI₄ (n = 1). The intensity of diffraction peaks of (BA)₂PbI₄ are stronger than that of MAPbI₃ which implies that the reaction rate is very fast and BA treatment may completely convert MAPbI₃ into (BA)₂PbI₄ when the treatment time is long enough. For BAI-treated films, some additional diffraction peaks are also observed. They are indexed to be the (002) plane of (BA)₂PbI₄ (n = 1), (040), (060), (111), (0k0), and (222) planes of 2D perovskites with n = 2, and (111) and (222) planes of 2D perovskite layer with n = 3, 4, indicating the formation of a 2D perovskite mixture with different n values.

The optical absorption of pristine, BA-treated, and BAI-treated MAPbI₃ films with different reaction times was investigated. The UV–vis absorption spectra of the 2D (BA)₂(MA)ₙ₋₁PbI₃₊₁ family (n = 1–4) had been previously reported. The excitonic absorption peaks could be observed at 2.44, 2.17, 2.04, and 1.93 eV for n = 1, 2, 3, and 4, respectively. As clearly shown in Figure 2b, an additional absorption peak at 2.44 eV was observed in BA-treated MAPbI₃ thin films after reaction for 3 min. When the reaction time increased to 5 and 10 min, this absorption peak could still be recognized with the same photon energy. This absorption peak corresponds to the excitonic absorption from 2D perovskite (BA)₂PbI₄ (n = 1), which agrees well with the XRD result in Figure 2a. The UV–vis absorption spectra of BAI-treated MAPbI₃ films are shown in Figure 2c; two peaks located at 2.04 and 1.93 eV can be clearly resolved with a reaction time of 3 min, corresponding to the excitonic absorption from 2D perovskites with n = 3 and 4, respectively. When the reaction time was increased to 5 min, an extra peak at 2.17 eV showed up, which was located at the same position as the excitonic absorption peak of 2D perovskites with n = 2. Upon further increasing the reaction time to 10 min, two high energy peaks (2.44 and 2.17 eV) stood out, which were indexed to be excitonic absorption from 2D perovskites with n = 1 and 2, while two low-energy peaks gradually merged into the continuum absorption spectrum of 3D perovskites. It is concluded that a mixture of 2D perovskites with a variety of layer numbers is formed after BAI treatment.

The surfaces of 3D perovskite films made by a regular solution process have been shown to be defective, while some charge transport materials were found to passivate the surface defects of perovskite films. We speculate that the formation
of 2D perovskites may also heal the surface defects due to the conversion of the defective surface of 3D perovskites into 2D perovskites. Time-resolved photoluminescence (TRPL) measurement has been conducted to examine the defect passivation effects of BA and BAI treatments on MAPbI₃ films. The TRPL measurements revealed an increased carrier lifetime for the MAPbI₃ films after both BA and BAI treatments, as shown in Figure 3a,b. The carrier lifetime of the pristine MAPbI₃ film was 16 ns, and after BA treatment, the carrier recombination lifetime was increased to 52, 122, and 204 ns when increasing the concentration of BA solution for spin-coating to 0.1, 0.3, and 1% v/v, respectively. For BAI treatment, when increasing the BAI concentrations to 1, 2, and 4 mg/mL, the carrier lifetime was increased to 48, 56, and 194 ns, respectively.

The photovoltaic devices had a structure of indium tin oxide (ITO)/poly(bis(4-phenyl)(2,4,6-trimethylphenyl)amine) (PTAA)/perovskite/[6,6]-phenyl-C61-butyric acid methyl ester (PCBM)/C₆0/2,9-dimethyl-4,7-diphenyl-1,10-phenanthroline (BCP)/Cu (Figure 3c). The photovoltaic performance of devices treated by BA and BAI was optimized with different solution concentrations, and the photocurrent density–voltage (J–V) characteristics are shown in Figure 3d. The substantial improvements in performance produced by BA and BAI treatments are reflected in all photovoltaic metrics (see Table S4). Compared to the control device (Jₚ: 22.20 mA/cm²; Vₒc: 1.08 V; FF: 0.74; PCE: 17.75%), the best device achieved for BA treatment had a Jₚ of 22.49 mA/cm², a Vₒc of 1.11 V, a FF of 0.78, and a PCE of 19.56%. For BAI-treated devices, the best obtained PCE was 18.85% (Jₚ: 22.59 mA/cm²; Vₒc: 1.09 V; FF: 0.77). The J–V characteristics of forward and reverse scanning for the best cells were recorded (Figure 3e), with no obvious hysteresis observed (see Table S4 for detailed photovoltaic parameters).

Figure 3. PL decay comparison for control (MAPbI₃ films) and BA-treated MAPbI₃ films (a) and control and BAI-treated MAPbI₃ films (b) with different concentrations; schematic figure of the device structure (c), J–V characteristics for the best cells (d), comparison of forward and reverse scans (e), and maximum power point tracking under continuous 1 sun illumination (f) of the control, BA-treated, and BAI-treated devices.

The capability of 2D/3D stacking structures toward thermal stress was investigated. Capacitance vs frequency measurement was adopted to investigate the device degradation caused by thermal stress. The spectra of fresh devices and aged devices (heated at 85 °C for 20 h) are displayed in Figure 4a,b, respectively. For fresh devices, no obvious difference can be observed in the capacitance–frequency spectra. After thermal stress, the device based on 3D MAPbI₃ exhibits nearly 1 order of magnitude larger capacitance than that of the fresh devices in the low-frequency region, while similar capacitance in the high-frequency region, as shown in Figure 4c. The detailed statistical data is summarized in Table S2. The J–V curves are shown for the best cells in Figure 3d (reverse scan). The substantial improvements in performance produced by BA and BAI treatments are reflected in all photovoltaic metrics (see Table S3). Compared to the control device (Jₚ: 22.20 mA/cm²; Vₒc: 1.08 V; FF: 0.74; PCE: 17.75%), the best device achieved for BA treatment had a Jₚ of 22.49 mA/cm², a Vₒc of 1.11 V, a FF of 0.78, and a PCE of 19.56%. For BAI-treated devices, the best obtained PCE was 18.85% (Jₚ: 22.59 mA/cm²; Vₒc: 1.09 V; FF: 0.77). The J–V characteristics of forward and reverse scanning for the best cells were recorded (Figure 3e), with no obvious hysteresis observed (see Table S4 for detailed photovoltaic parameters). A stable output photocurrent density and PCE of these champion cells were obtained under the standard 1 sun illumination (Figure 3f). Compared to the control device (17.28%), higher PCEs of 19.29 and 18.51% were achieved in BA- and BAI-treated devices, respectively.

For BAI-treated devices, the optimized PCE was obtained with a concentration of 1 mg/mL. Similarly, when the concentration was further increased, the device performance got worse. Figure S3 provides statistical data on the reproducibility of the solar cell performance. Under simulated 1 sun illumination, average efficiencies of 17.05% (s.d. (standard deviation) ± 0.30), 18.89% (s.d. ± 0.34), and 18.17% (s.d. ± 0.31) were obtained from 40 devices for pristine, BA-treated, and BAI-treated MAPbI₃, respectively. The detailed statistical data is summarized in Table S2. The J–V curves are shown for the best cells in Figure 3d (reverse scan). The substantial improvements in performance produced by BA and BAI treatments are reflected in all photovoltaic metrics (see Table S3). Compared to the control device (Jₚ: 22.20 mA/cm²; Vₒc: 1.08 V; FF: 0.74; PCE: 17.75%), the best device achieved for BA treatment had a Jₚ of 22.49 mA/cm², a Vₒc of 1.11 V, a FF of 0.78, and a PCE of 19.56%. For BAI-treated devices, the best obtained PCE was 18.85% (Jₚ: 22.59 mA/cm²; Vₒc: 1.09 V; FF: 0.77). The J–V characteristics of forward and reverse scanning for the best cells were recorded (Figure 3e), with no obvious hysteresis observed (see Table S4 for detailed photovoltaic parameters). A stable output photocurrent density and PCE of these champion cells were obtained under the standard 1 sun illumination (Figure 3f). Compared to the control device (17.28%), higher PCEs of 19.29 and 18.51% were achieved in BA- and BAI-treated devices, respectively.

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frequency region. The capacitance in the low-frequency regime may be attributed to ionic migration to the contact interface. At moderately high temperature, the cationic and halide components in 3D MAPbI$_3$ can easily escape from the surface, producing high-density iodine and MA vacancies in perovskite materials facilitating ionic motion, which results in increased capacitance in the low-frequency regime. This thermal decomposition usually starts from the surface and grain boundaries where there is higher defect density. As illustrated in Figure 4c, the 2D perovskite layer at the surface and grain boundaries in a 2D/3D stacking structure could effectively suppress the formation of mobile ions under elevated temperature as compared to 3D perovskites. In 3D perovskites, the volatilization of MA or I$_2$ from the crystal surface or grain boundaries should be the major reason for the formation of mobile MA and iodine vacancies. The larger size of BA$^+$ as compared to MA$^+$ is supposed to play a key role in stopping the volatilization of MA or I$_2$. This is because neither the volatilization of the BA$^+$ ion itself nor the exchanges of BA$^+$ with inner MA$^+$ ions is easy. In our previous publication, we showed that using larger organic cation BA$^+$ could increase the ion migration potential barrier, which also helps to suppress the escape of volatile ions from the perovskite crystal.

The stability of the devices was evaluated in an accelerated mode. Because the encapsulated devices last more than 1 month under illumination, here the nonencapsulated devices were evaluated under an elevated temperature of 95 °C and were compared with control devices. Here, seven devices were tested for each condition. The normalized average PCEs along the time testing are shown in Figure 4d. The control device degraded to 69.8% of its initial efficiency after continuous heating for 100 h, while the modified devices still maintained 96.5% and 88.2% of their initial efficiencies for devices with BA and BAI treatments, respectively. The deterioration of device performance appears quite well with the thermal study observed above. The comparison of normalized $J_{sc}$, $V_{oc}$, FF, and PCE of the control, BA-treated, and BAI-treated devices in thermal stability tests is summarized in Figure S4.

In summary, the perovskite solar cells with 2D/3D stacking structures were achieved by two different post-treatment methods. The compositions of resulting 2D perovskites are different due to the different chemical reaction mechanisms. However, both perovskite solar cells with 2D/3D stacking structures were demonstrated to be effective in enhancing the device performance by passivation and self-healing effects. Meanwhile, these structures have much better thermal stability than conventional 3D perovskite solar cells due to the reduced defect density and suppressed ion migration on the surface and at grain boundaries. Our work provides insight on the chemical reaction mechanism of forming 2D/3D stacking structures and provides a new avenue to tune the 2D/3D stacking structures by adopting different post-treatments as well as increasing both the performance and stability of perovskite solar cells.


(31) Liu, J.; Leng, J.; Wu, K.; Zhang, J.; Jin, S. Observation of Internal Photoinduced Electron and Hole Separation in Hybrid Two-